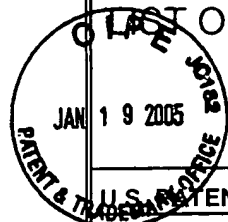


SHEET 1 OF 1

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\\fk4\Documents\2000\2000-698\84391.doc



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(PTO-1449)

ATTY. DOCKET NO.
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2681

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE

U.S. PATENT APPLICATION PUBLICATIONS

EXAMINER'S INITIALS	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	FILING DATE

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FOREIGN PATENT DOCUMENTS :

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
c.c.	KR 10-2000-0055309	09/05/2000	Korean (Full Text & English Abstract)				
c.c.	KR 10-2001-0095498	11/01/2001	Korean (Full Text & English Abstract)				

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

c.c.	Korean Office Action

EXAMINER

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